


<b>Search Notes</b>  	<b>Application/Control No.</b>  10587268	<b>Applicant(s)/Patent Under Reexamination</b>  TAKAIWA ET AL.
	<b>Examiner</b>  Michael Liu	<b>Art Unit</b>  2851

SEARCHED			
Class	Subclass	Date	Examiner
355	30, 53, 55, 67	6/11/08	ML

SEARCH NOTES		
Search Notes	Date	Examiner
See EAST search history printout.	6/11/08	ML

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner